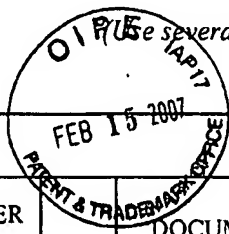


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| FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i> | ATTY. DOCKET NO. 59559.00024 | SERIAL NO. 10/559,793 |
| | APPLICANT Akihisa KOBAYASHI, et al. | |
| | FILING DATE December 8, 2005 | GROUP 1764 |



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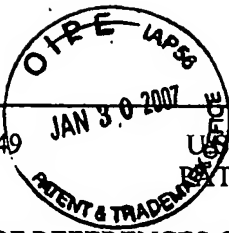
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| | AA | | | | | |
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| | | DOCUMENT NO. | DATE | COUNTRY | | <u>TRANSLATION</u> YES NO PART. | | |
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| /DB/ | AG | EP 1 388 404 B1 | February 11, 2004 | European | Corresponds to DE 101 43 013 A1 | | | X |
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| /DB/ | AK | WO 02055886 | August 14, 2002 | PCT | Corresponds to DE 102 01 183 A 1 | | | X |
| /DB/ | AL | DE 102 01 183 A 1 | August 14, 2002 | German | | | X | |
| | AM | | | | | | | |

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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| | AL | |
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| FORM PTO-1449 | U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE | ATTY. DOCKET NO. 59559.00024 | SERIAL NO. 107559793 Not Yet Assigned |
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| | | FILING DATE December 8, 2005 | GROUP Not Yet Assigned |

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| | | DOCUMENT NO. | DATE | COUNTRY | CLASS | SUB- CLASS | TRANSLATION YES NO PART. | | |
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